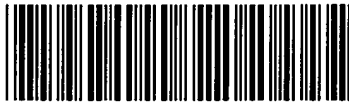


Search Notes

Application/Control No.

10/657,331

Examiner

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Applicant(s)/Patent under
Reexamination

MOYER, WILLIAM C.

Art Unit

2183

SEARCHED

Class	Subclass	Date	Examiner
712	4 22 225	12/21/2006	DP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WESY pgp uspat epoabs derwent IBM TD IEEE NPL 710/52, 60 tran. dat. 712/300, 225 711/171-173	12/21/2006	DP